

# What are MODFETs? - MOSFET Threshold Values, $I_D$ - $V_{GS}$ Characteristics, and Temperature Characteristics

## Si Transistors

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In succession to the preceding discussion of MOSFET switching characteristics, here we explain the gate threshold voltage, which is a crucial characteristic of MOSFETs, as well as the  $I_D$ - $V_{GS}$  characteristics, and the temperature characteristics of each of these.

### MOSFET $V_{GS(th)}$ : Gate Threshold Voltage

The MOSFET  $V_{GS(th)}$  or gate threshold voltage is the voltage between the gate and source that is needed to turn on the MOSFET. In other words, if  $V_{GS}$  is at least as high as the threshold voltage, the MOSFET turns on.

Some persons may be wondering just how much of a current  $I_D$  can be passed on this "MOSFET on" state. And it is true that  $I_D$  changes depending on  $V_{GS}$ . Speaking from the standpoint of the  $V_{GS(th)}$  specification, if the conditions are not determined, a value for  $V_{GS(th)}$  cannot be guaranteed; the datasheet for the MOSFET stipulates these conditions. This table is excerpted from the datasheet for the N-ch, 600 V, 4 A power MOSFET [R6004KNX](#).

● **Electrical characteristics** ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Drain - Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 1\text{mA}$	600	-	-	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 600\text{V}, V_{GS} = 0\text{V}$ $T_j = 25^\circ\text{C}$	-	-	100	$\mu\text{A}$
		$T_j = 125^\circ\text{C}$	-	-	1000	
Gate - Source leakage current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$	-	-	$\pm 100$	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = 10\text{V}, I_D = 1\text{mA}$	3	-	5	V
Static drain - source on - state resistance	$R_{DS(on)}^{*5}$	$V_{GS} = 10\text{V}, I_D = 1.5\text{A}$ $T_j = 25^\circ\text{C}$	-	0.90	0.98	$\Omega$
		$T_j = 125^\circ\text{C}$	-	1.36	-	
Gate resistance	$R_G$	$f = 1\text{MHz}, \text{open drain}$	-	3.3	-	$\Omega$

The blue line surrounds information on  $V_{GS(th)}$ , and the conditions column indicates that conditions are  $V_{DS} = 10\text{ V}$  and  $I_D = 1\text{ mA}$ . Under these conditions, and at  $T_a = 25^\circ\text{C}$ ,  $V_{GS(th)}$  is guaranteed to have minimum and maximum values of 3 V and 5 V.

In other words, as  $V_{GS}$  is raised, the MOSFET begins to turn on ( $I_D$  begins to flow), and when  $I_D$  is 1 mA, the value of  $V_{GS}$  is between 3 V and 5 V inclusive; this value is  $V_{GS(th)}$ . Various methods of expression are possible, but we can say that the MOSFET on state is defined as being when  $I_D = 1\text{ mA}$  at  $V_{DS} = 10\text{ V}$ , and the  $V_{GS}$  at this time is taken to be  $V_{GS(th)}$ , the value of which is between 3 V and 5 V.

It should also be noted that voltages and currents that change according to some state, such as an input or output or a turning on or off of some function, are commonly called threshold values, and are not limited to MOSFETs.

**Temperature Characteristics of  $V_{GS(th)}$  and  $I_D$ - $V_{GS}$**

From the initial graph showing the  $I_D$ -

$V_{GS}$  characteristic, the  $V_{GS(th)}$  for the

MOSFET can be read off. The condition

$V_{DS} = 10\text{ V}$  matches the stipulated condition.

When  $I_D$  is 1 mA,  $V_{GS}$  is equal to  $V_{GS(th)}$ , and

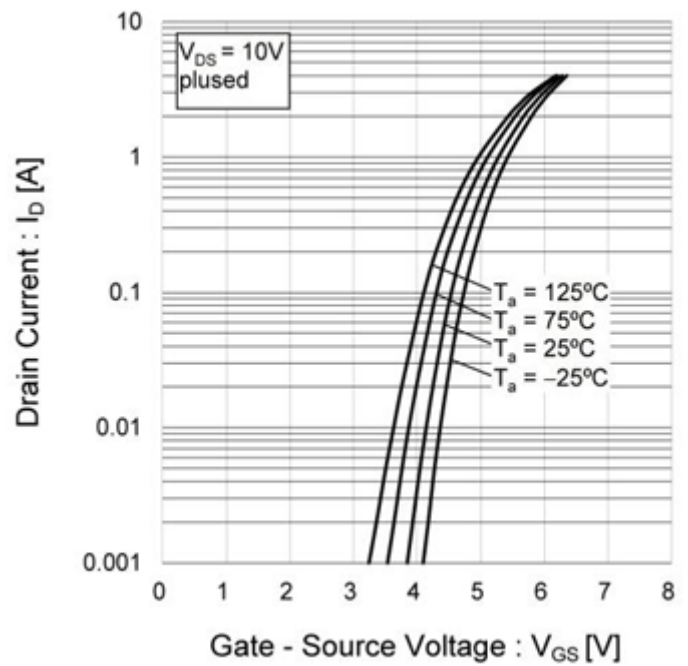
so the  $V_{GS}$  when the curve for  $T_a = 25^\circ\text{C}$

intersects the 1 mA (0.001 A) line is approx.

3.8 V. The datasheet does not indicate a

representative or typical value (indicated by "Typ"), and we see from the graph that the Typ value for  $V_{GS(th)}$  is about 3.8 V. The graph value can in essence be regarded as the Typ value.

Next, we consider the  $I_D$ - $V_{GS}$  characteristic. As the specification value for  $V_{GS(th)}$ , the value when  $I_D = 1$  mA is used, but in actual use, a 4 A MOSFET is unlikely to be used with  $I_D$  at only 1 mA. For example, when an  $I_D$  of 1 A at  $T_a = 25^\circ\text{C}$  is required, we see from the graph that the  $V_{GS}$  is about 5.3 V.



From the graph of the  $I_D$ - $V_{GS}$  temperature characteristic, at high temperatures there is a tendency for  $I_D$  to increase if  $V_{GS}$  is constant. Taking as an example the previous condition that  $I_D = 1$  A at  $T_a = 25^\circ\text{C}$ , at  $T_a = 75^\circ\text{C}$ , an  $I_D$  of about 1.5 A can be passed, and so the conditions of use must be considered carefully.

Returning to the gate threshold voltage, the temperature characteristic of  $V_{GS(th)}$  is shown in a graph. As was seen from the  $I_D$ - $V_{GS}$  graph, we see that at  $25^\circ\text{C}$ ,  $V_{GS(th)}$  is approx. 3.8 V. The temperature in this graph is  $T_j$ , but as indicated by the term "pulsed", the data was obtained in pulsed tests, and it is permissible to assume that  $T_j \approx T_a \approx 25^\circ\text{C}$ .

It is seen that the temperature characteristic is such that at high temperatures,  $V_{GS(th)}$  tends to decline. This indicates that as the temperature rises, because  $V_{GS(th)}$  declines, a larger  $I_D$  can flow at a lower  $V_{GS}$ . In other words, and as would be expected, this matches the  $I_D$ - $V_{GS}$  temperature characteristic.

$V_{GS(th)}$  can be used to estimate  $T_j$ . The  $V_{GS(th)}$  temperature characteristic is linear, and so a proportionality coefficient can be calculated, and the increase in temperature can be calculated from the amount of change in  $V_{GS(th)}$ .